

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10598971	OSHIYAMA ET AL.
	Examiner	Art Unit
	Vu Nguyen	1796

SEARCHED

Class	Subclass	Date	Examiner
546	10	1/20/2010	/V.N./
	13		
	84		
428	690		
	917		
313	504		
	506		
257	E51.041	1/20/2010	/V.N./

SEARCH NOTES

Search Notes	Date	Examiner
Inventor search (eDAN, PALM, EAST)	1/8/2010	/V.N./
See STIC Search results	1/13/2010	/V.N./
See EAST search report	1/20/2010	/V.N./
Google search	1/19/2010	/V.N./

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
546	10	4/29/2010	/V.N./
	13		
	84	4/29/2010	/V.N./

/Vu Nguyen/
Examiner.Art Unit 1796